

Supporting Information for

Controlling fluorescence emission with split-ring-resonator-based plasmonic metasurfaces

Si Luo, Qiang Li*, Yuanqing Yang, Xingxing Chen, Wei Wang, Yurui Qu, and Min Qiu

State Key Laboratory of Modern Optical Instrumentation, College of Optical Science and Engineering, Zhejiang University, Hangzhou 310027, China,

The Supporting Information includes the following contents:

I. The experimental setup to characterize the fluorescence properties

II. Mode analysis at different incident angles

III. Fundamental magnetic resonance at x-polarized incidence

IV. The absorbance and emission spectra of Rh 800.

V. Fluorescence enhancement factors compared with the calculated electric field enhancements.

I. The experimental setup to characterize the fluorescence properties

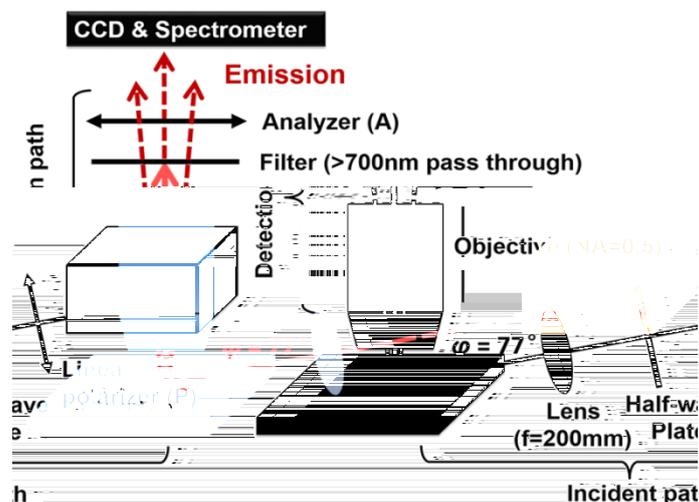


Figure S1. A schematic diagram depicting the control over the fluorescence emission with the SRR-based plasmonic metasurface

II. Mode analysis at different incident angles

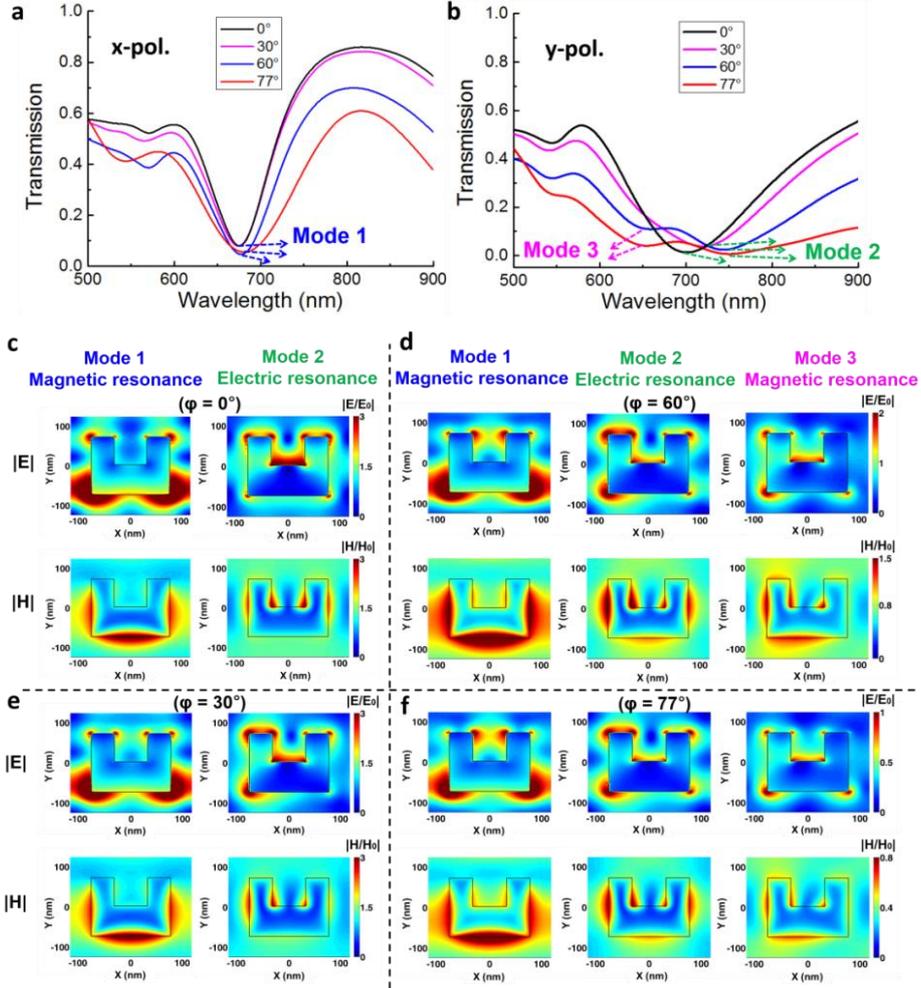


Figure S2. (a, b) Simulated transmission spectra of the SRR based metasurface at x-polarized and y-polarized incidence. The spectra at different incident angles of $\varphi = 0^\circ$ (black), $\varphi = 30^\circ$ (pink), $\varphi = 60^\circ$ (blue) and $\varphi = 77^\circ$ (red) are denoted. Three resonant modes are marked. (c-e) Simulated electric and magnetic field intensity distributions of the corresponding resonant modes at different incident angles of (c) $\varphi = 0^\circ$, (d) $\varphi = 30^\circ$, (e) $\varphi = 60^\circ$ and (f) $\varphi = 77^\circ$.

For x-polarized incidence, the resonant wavelength of the magnetic mode (Mode 1) remains almost unchanged with incident angles φ varying from 0° to 77° (Fig. S2a). The electric and magnetic field distributions of Mode 1 are also similar at different incident angles φ (Fig. S2c-f).

For y-polarized incidence, the resonant wavelength of the electric mode (Mode 2) is red-shifted with increasing incident angles φ (Fig. S2b). A new magnetic mode (Mode 3) emerges with similar electric and magnetic field distributions at 60° and 77° oblique incidence.

III. Fundamental magnetic resonance at x-polarized incidence

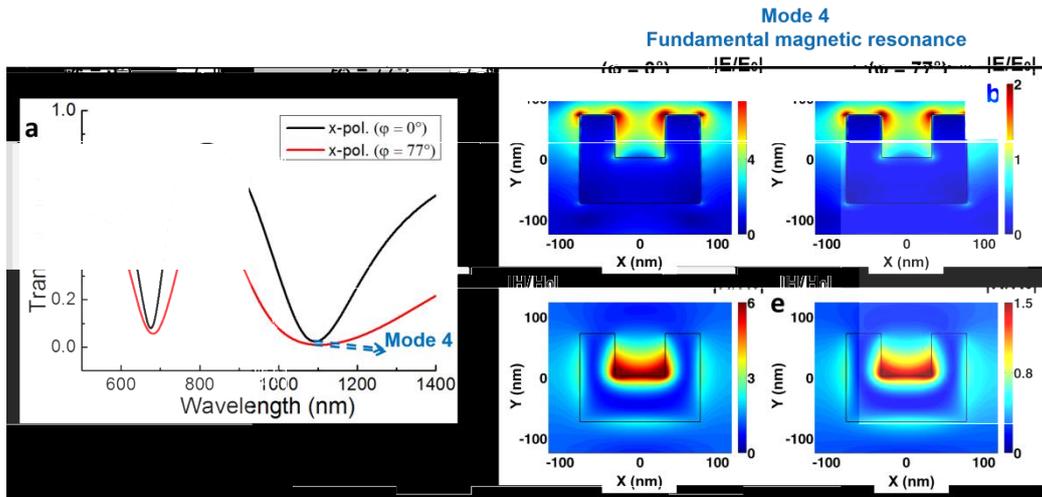


Figure S3. (a) Simulated transmission spectra of the SRR based metasurface at x-polarized incidence. The black and red lines denote the incident angles of $\varphi = 0^\circ$ and $\varphi = 77^\circ$, respectively. The fundamental magnetic modes (Mode 4) at around 1100 nm are marked with arrows. (b, d) Simulated electric (b) and magnetic (d) field intensity distributions of Mode 4 at normal incidence ($\varphi = 0^\circ$) (c, e) Simulated electric (c) and magnetic (e) field intensity distributions of Mode 4 at oblique incidence ($\varphi = 77^\circ$).

IV. The absorbance and emission spectra of Rh 800.

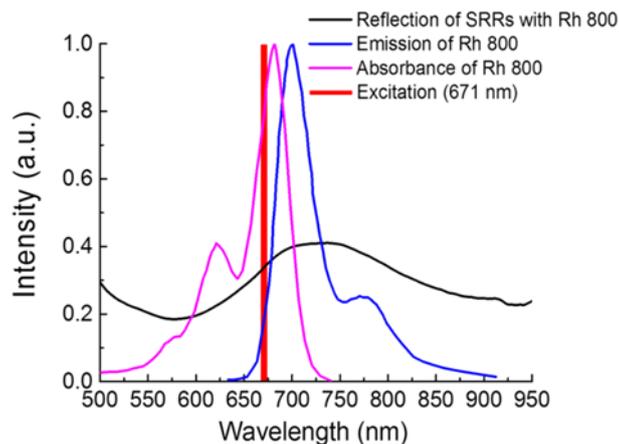


Figure S4. The resonance (the reflection of the SRR-based metasurface with dyed PVA film) is plotted with the absorption and emission spectra of the dye. (The absorbance and emission spectra data are adopted from Ref. [53].)

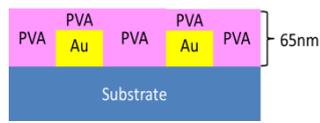
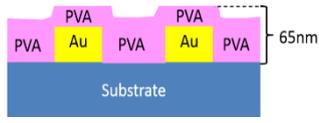
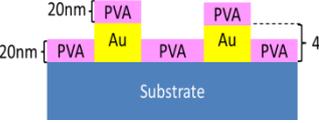
[53] A. Alessi, M. Salvalaggio, and G. Ruzzon, *J. Lumin.* **134**, 385–389 (2013).

V. Fluorescence enhancement factors compared with the calculated electric field enhancements.

Table S1. Calculated field enhancement factor and experimental fluorescence enhancement factor at 77° oblique incidence.

| Incident Polarization | $\left(\frac{E}{E_0}\right)_{671}^2$ (Cal.) | $\left(\frac{E}{E_0}\right)_{706}^2$ (Cal.) | $\left(\frac{E}{E_0}\right)_{671}^2 \left(\frac{E}{E_0}\right)_{706}^2$ (Cal.) | EF (Exp.) |
|-----------------------|---|---|--|-----------|
| x-pol. | 5.73 | 5.19 | 29.74 | 18 |
| y-pol. | 2.80 | 3.46 | 9.69 | 8 |

Table S2. Calculated field enhancement factor and experimental fluorescence enhancement factor with the cross-section schematics of two side arms coated with different thickness of PVA shown in the insets.

| | Case I | Case II | Case III |
|-----------------------|---|---|---|
| Incident Polarization | $\left(\frac{E}{E_0}\right)_{671}^2 \left(\frac{E}{E_0}\right)_{706}^2$ (sim.)  | EF (exp.)  | $\left(\frac{E}{E_0}\right)_{671}^2 \left(\frac{E}{E_0}\right)_{706}^2$ (sim.)  |
| x-pol. | 29.74 | 18 | 14.20 |
| y-pol. | 9.69 | 8 | 4.64 |

*The measured thickness of the gold film and the spin-coated PVA film is 45 nm and 20 nm, respectively.